

# WEST Search History

DATE: Wednesday, September 18, 2002

<u>Set Name</u> side by side	<u>Query</u>	<u>Hit Count</u>	<u>Set Name</u> result set
<i>DB=USPT; PLUR=YES; OP=OR</i>			
L7	6456099.pn.	0	L7
<i>DB=USPT,PGPB,JPAB,EPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>			
L6	L5 and test\$3	106	L6
L5	((wir\$3 near4 bond\$3) with pad\$1) with connect\$3 with (solder adj (ball\$1 or bump\$1))	343	L5
L4	((bond\$3 with pad\$1) and (solder adj (ball\$1 or bump\$1))).ab. and (KGD or (known adj good))	25	L4
<i>DB=USPT; PLUR=YES; OP=OR</i>			
L3	L2 not L1	10	L3
L2	(slot\$1 with (carrier or interposer)) and ((open\$3 or slot\$1) with (stress or strain)) and ((carrier or interposer) with (silicon or ceramic))	14	L2
L1	(semiconductor with carrier) and (slot\$1 with carrier) and (slot\$1 with (stress or strain)) and (carrier with (silicon or ceramic))	4	L1

END OF SEARCH HISTORY